

2007 TUTORIAL

ARCHIVE 2007

TUTORIAL 1

"ATE PRINTED CIRCUIT BOARD DESIGN; PERFORMANCE VS. DESIGN FOR MANUFACTURABILITY VS. TIME TO TEST"

by

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CURRENT PRINTED CIRCUIT BOARD design requirements have challenged the manufacturing processes to new limits. In the ATE industry in particular, test performance, signal speeds, multi-site device testing and shortened time to test demands have pushed the PCB Industry to more layers, tighter pitch, higher aspect ratios, exotic materials and customized processes. At times, the consequences have been poor yields, extensive test floor trouble-shooting, longer lead times and higher costs. This tutorial will address several of the performance drivers, along with the possible trade-offs associated with each of them, to give the Test Engineer a choice.

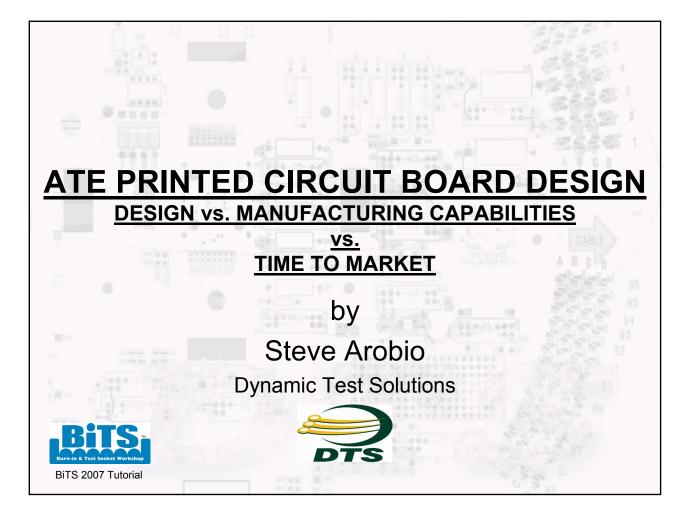
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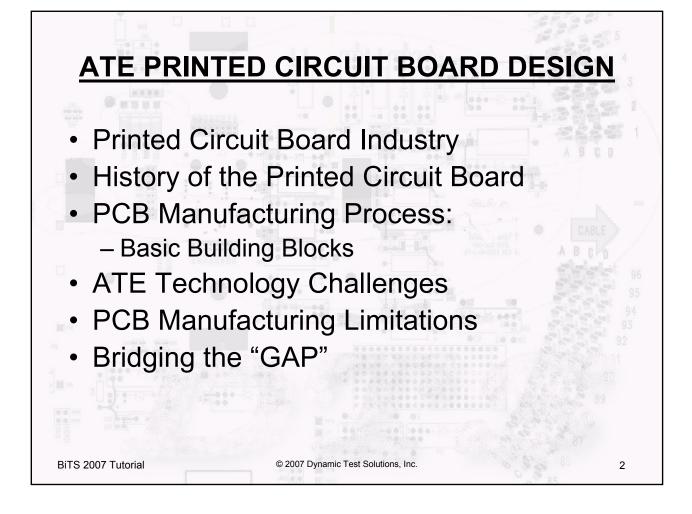
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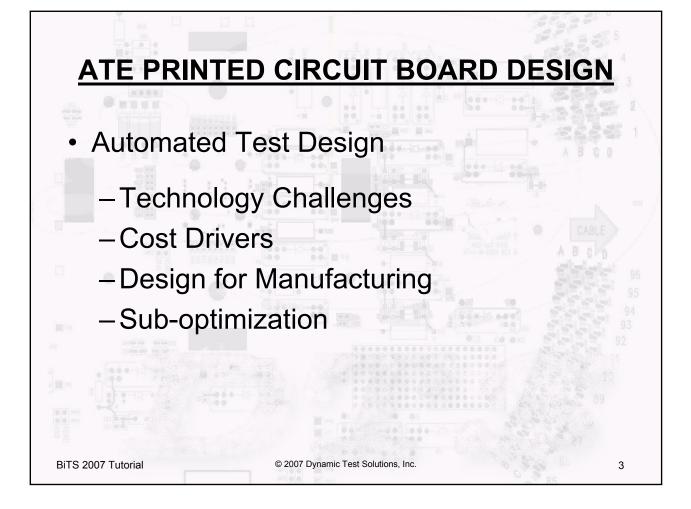




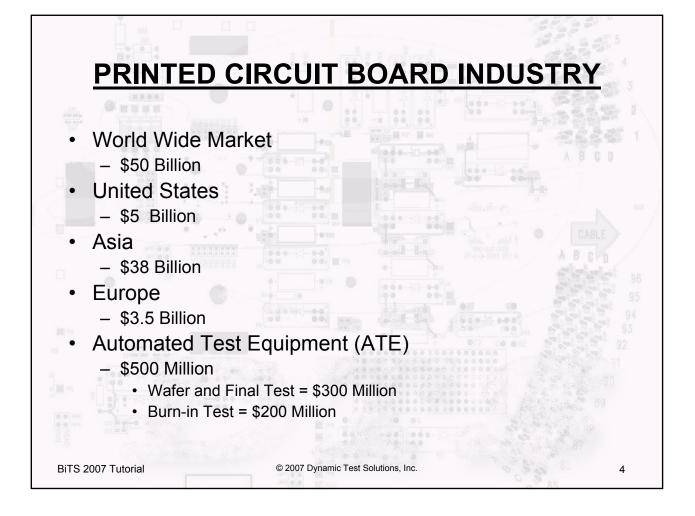




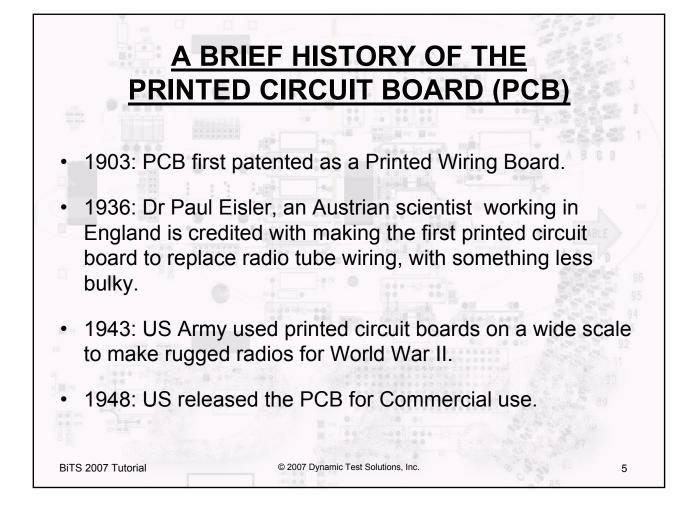




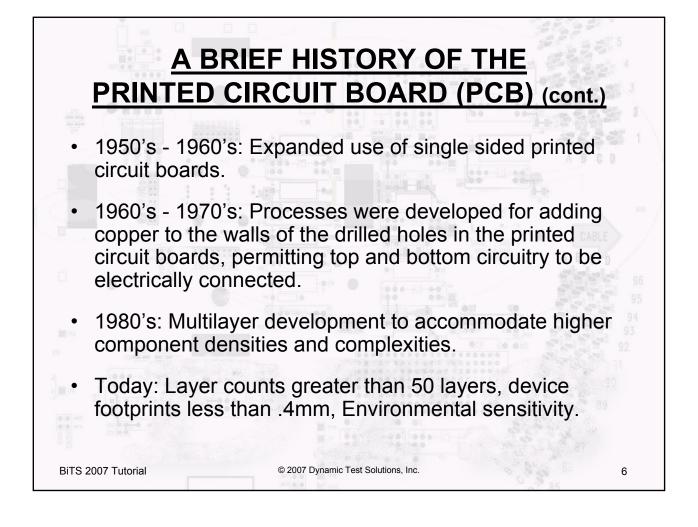








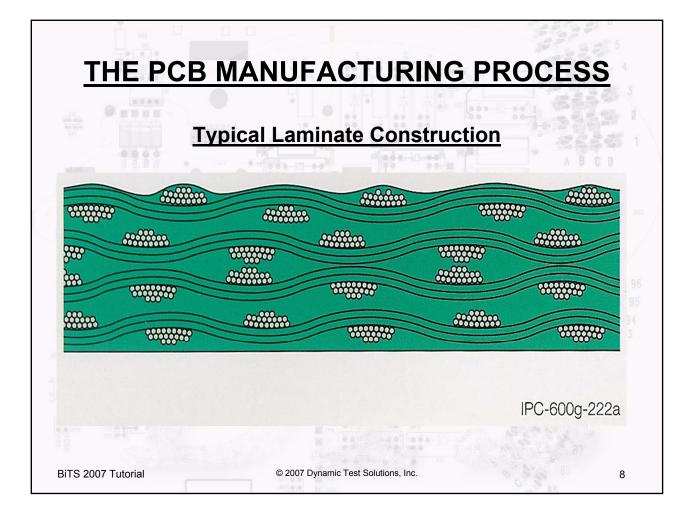






THE PCB MANUFACTURING PROCESS
 Materials Release / Shear Insulators / Dielectric Material Base Laminate – Fully cured, glass reinforced resin impregnated composite material. Pre-preg – Semi-cured (B-stage), glass reinforced resin impregnated composite material. Critical Material Characteristics to Consider Glass Transition (Tg): The temperature at which the resin
 <u>Dialss Transition</u> (Tg): The temperature at which the reshrunce turns from a "glassy" state to a plastic state. Operating above Tg results in expansion of the material, and in particular, in the Z-axis. <u>Dielectric Constant</u> (Dk): Is the measure of the extent of a material to which it concentrates electrostatic lines of flux. It is the ratio of the amount of stored energy when a potential is applied, relative to the permittivity of a vacuum. <u>Loss Tangent</u>: Also known as the dissipation factor, it is the ratio of the power loss in a dielectric material to the total power transmitted through the dielectric, the imperfection of the dielectric.





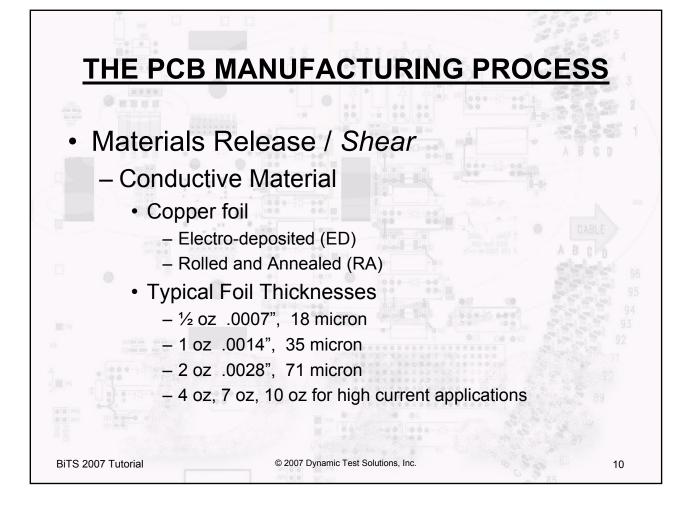


THE PCB MANUFACTURING PROCESS

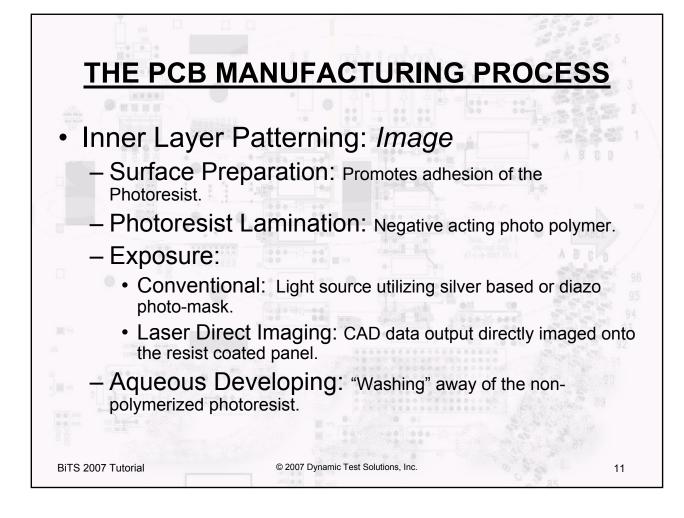
Materials Release / Shear Insulators / Dielectric Material Commonly Used Laminates

Material Type	<u>Ta</u>	Dk	Loss Tangent	Cost Factor CABLE
Standard FR-4	165 C	4.30	.0250 @ 1 MHz	1.0 A B C
High Temp. FR-4	180 C	4.50	.0035 @ 1 MHz	1.2
Polyimide	260 C	3.40	.0035 @ 1 MHz	1.5
Rogers 4003	280 C	3.55	.0027 @ 10 GHz	2.0
Rogers 4350	280 C	3.66	.0037 @ 10 GHz	2.0
Nelco 4000-6	175 C	4.30	.0230 @ 1 MHz	1.0
Nelco 4000-13	210 C	3.60	.0080 @ 10 GHz	1.2
Nelco 4000-13SI	210 C	3.20	.0070 @ 10 GHz	1.5
Arlon 25 N	260 C	3.38	.0025 @ 10 GHz	N/A
Speedboard C	220 C	2.60	.0038 @ 3 GHz	N/A
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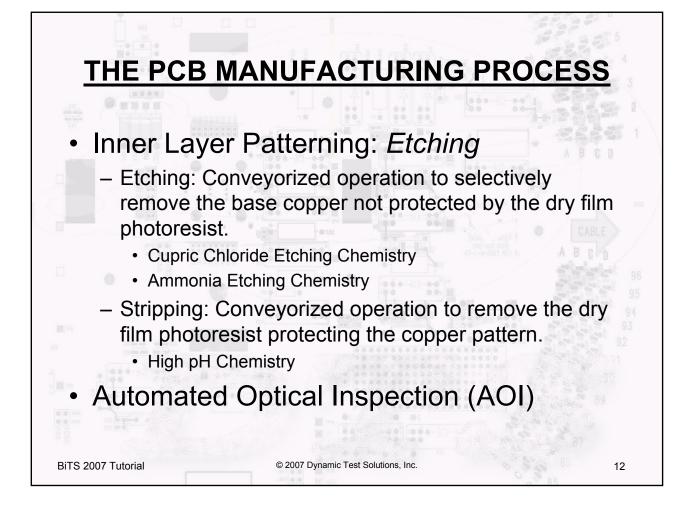




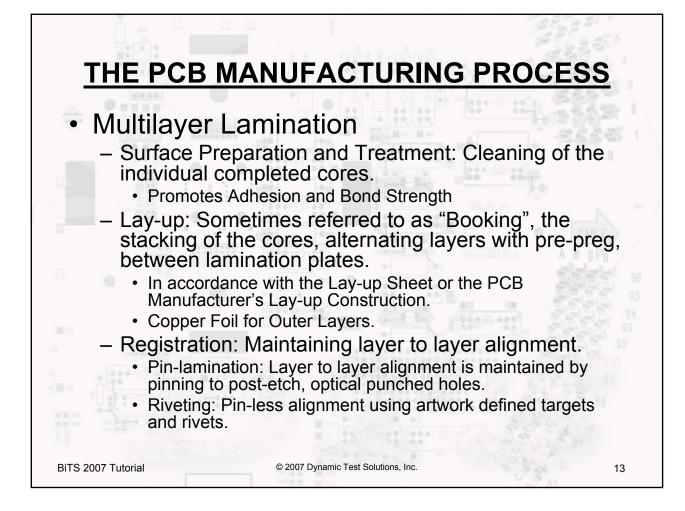




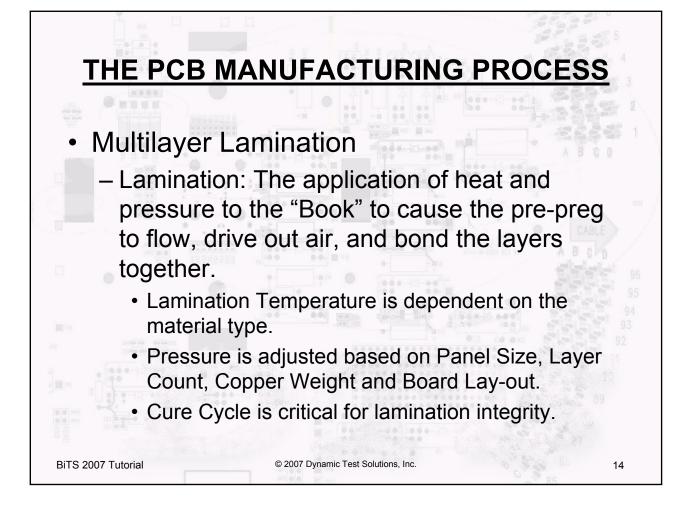




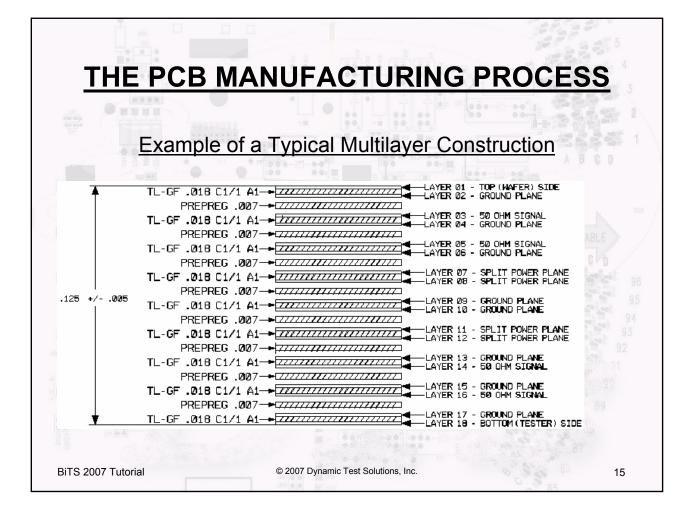




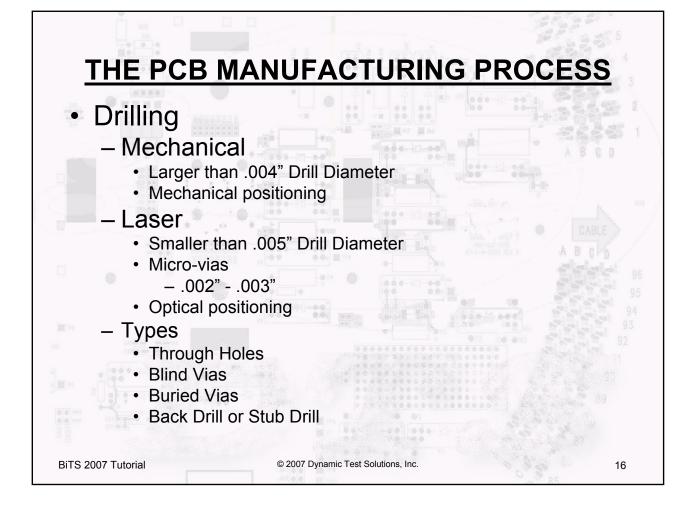




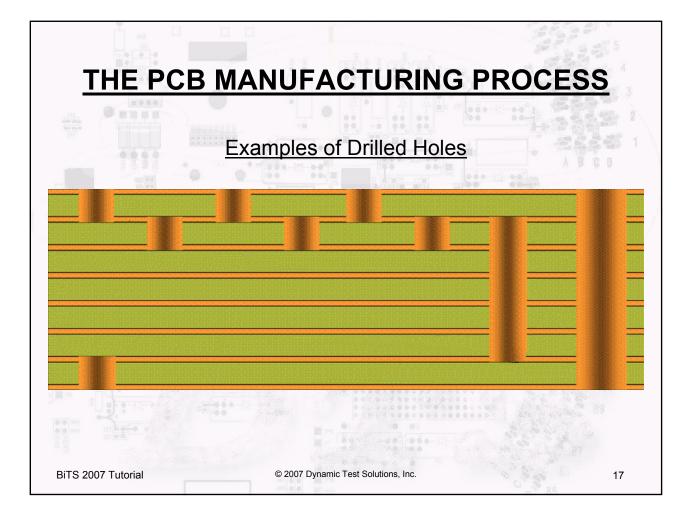




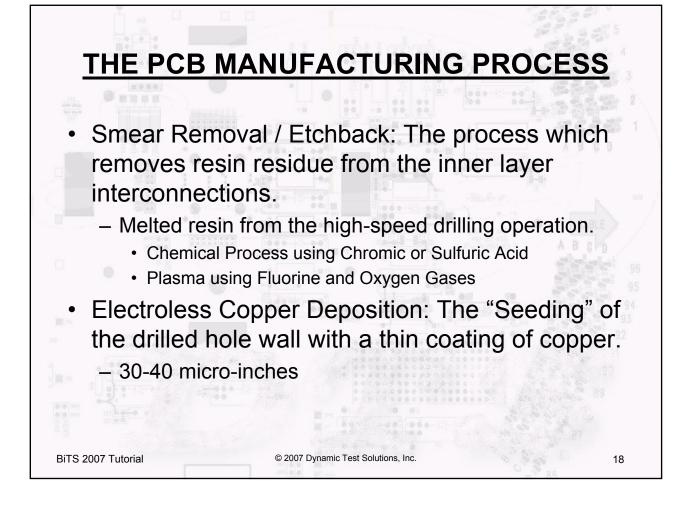




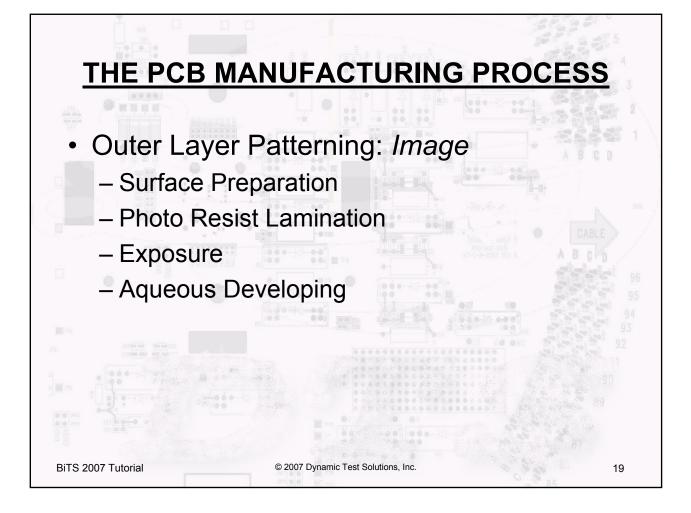




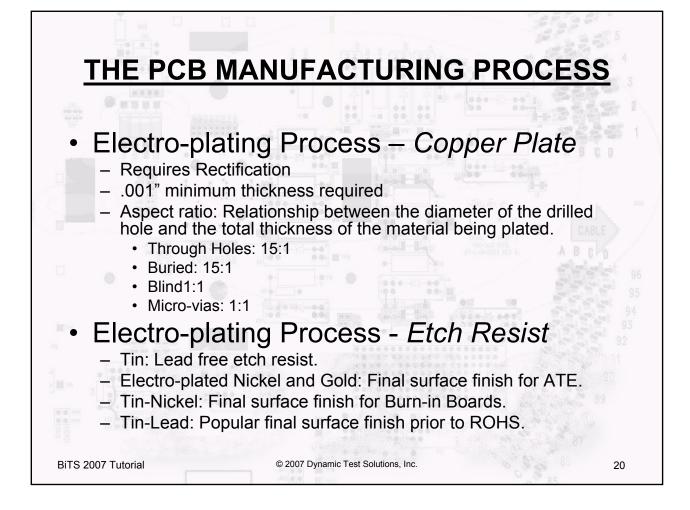




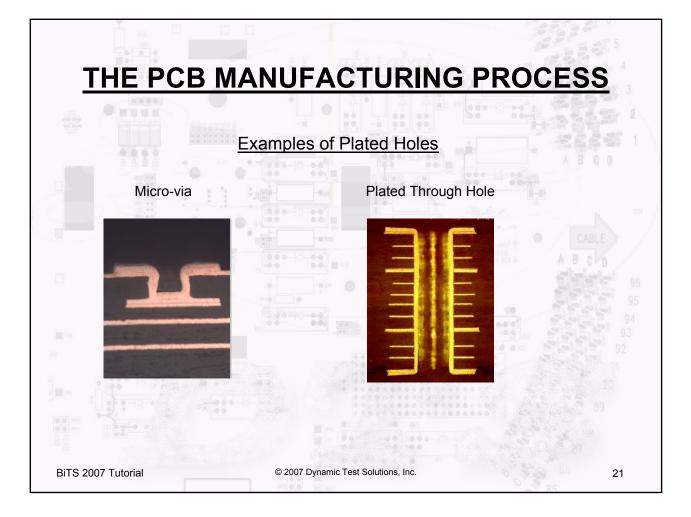




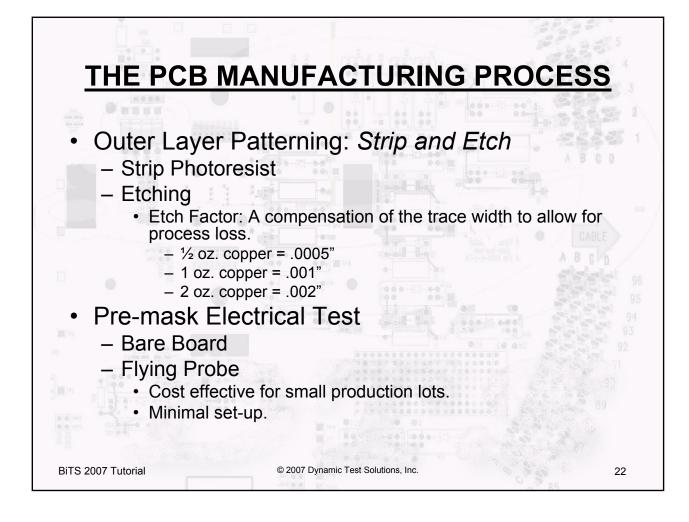




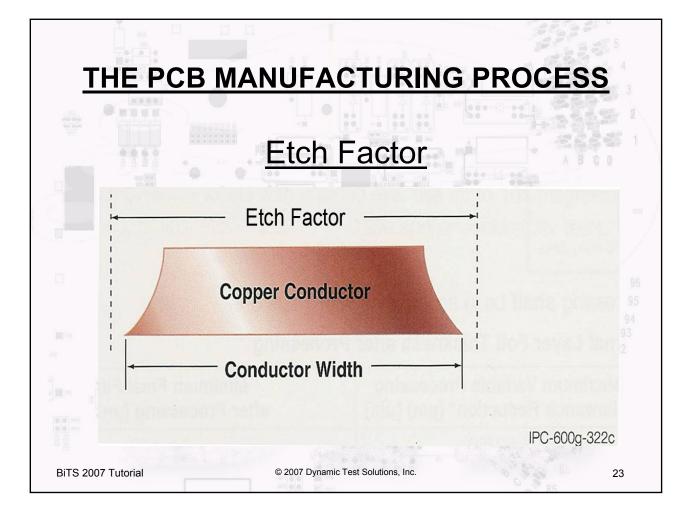




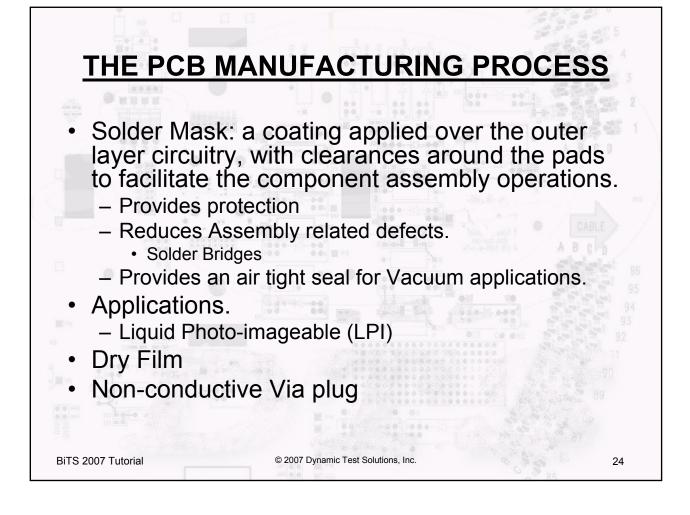




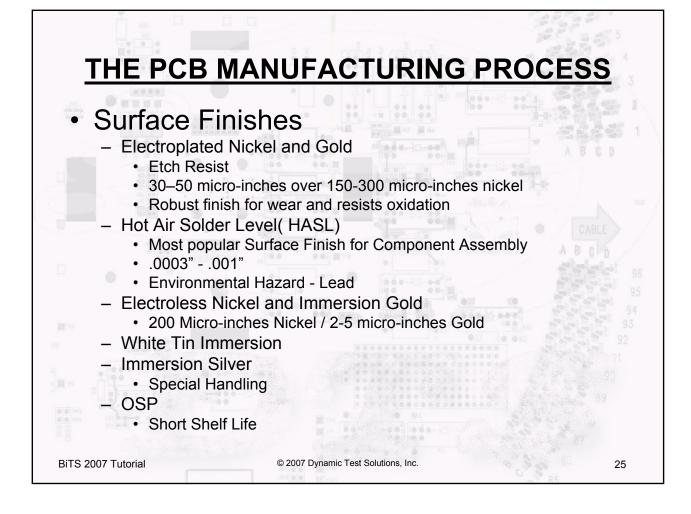




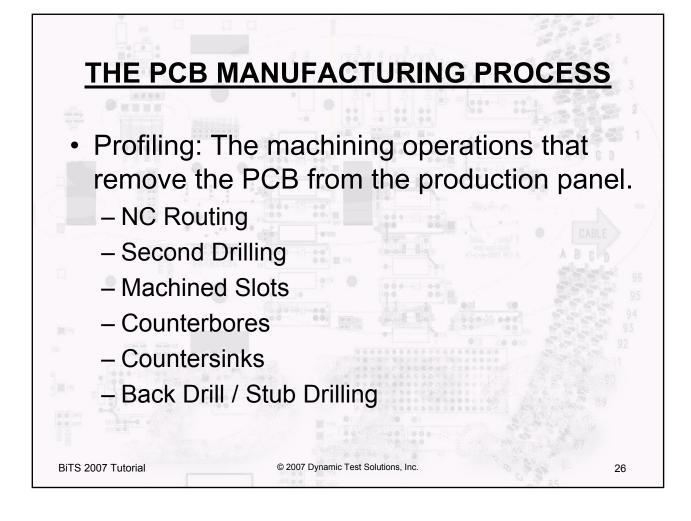




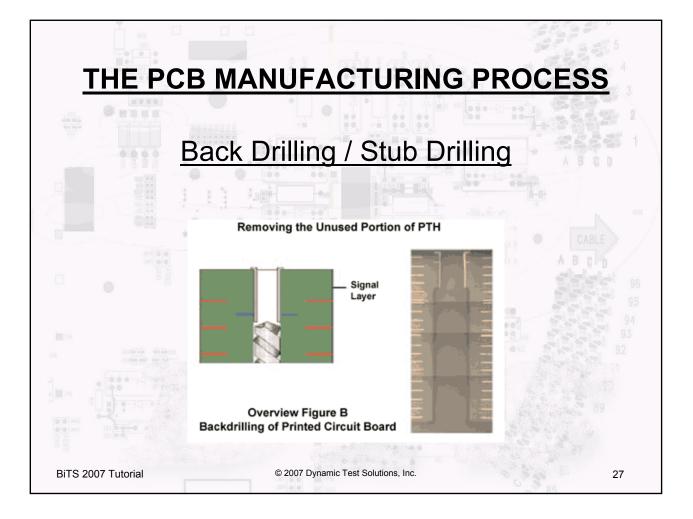




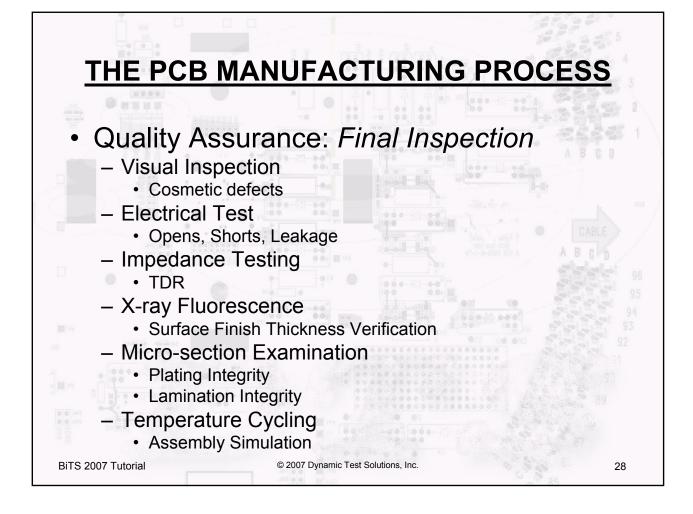












March 11 - 14, 2007



